Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/797,867	CHEN ET AL.
Examiner	Art Unit

Monica Lewis

2822

	SEARCHED				
Class	Subclass	Date	Examiner		
257	797	1/30/2007	ML		
313	581	1/30/2007	ML		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
East Search	1/30/2007	ML